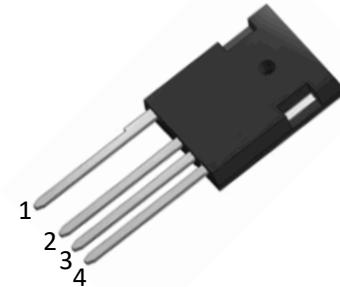


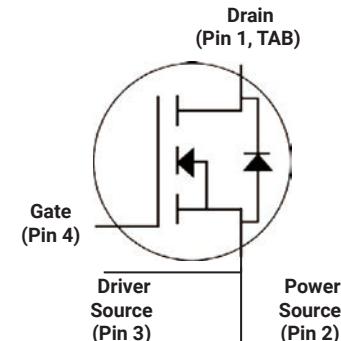


Features

- 3rd generation SiC MOSFET technology
- Optimized package with separate driver source pin
- High blocking voltage with low on-resistance
- High-speed switching with low capacitances
- Fast intrinsic diode with low reverse recovery (Q_{rr})
- Halogen free, RoHS compliant



TO-247-4L
Package



Benefits

- Reduce switching losses and minimize gate ringing
- Higher system efficiency
- Reduce cooling requirements
- Increase power density
- Increase system switching frequency

Applications

- Renewable energy
- EV battery chargers
- High voltage DC/DC converters
- Switch Mode Power Supplies

| Ordering Part Number | Package | Marking |
|----------------------|-----------|---------------|
| HC3M0045065K1 | TO-247-4L | HC3M0045065K1 |



Maximum Ratings (T_c = 25 °C unless otherwise specified)

| Parameter | Symbol | Value | Unit |
|--|-----------------------------------|------------|------|
| Drain-source voltage | V _{DS} | 650 | V |
| Continuous drain current | I _D | 49 53 | A |
| T _c = 25°C T _c = 100°C | | | |
| Pulsed drain current (T _c = 25°C, t _p limited by T _{jmax}) | I _D pulse | 123 | A |
| Avalanche energy, single pulse (L=10mH) | E _{AS} | 1000 | mJ |
| Gate-Source voltage | V _{GS} | -5/+20 | V |
| Gate-Source voltage (dynamic, Absolute maximum values) | V _{GSmax} | -10/+25 | V |
| Power dissipation (T _c = 25°C) | P _{tot} | 242 | W |
| Operating junction and storage temperature | T _j , T _{stg} | -55...+175 | °C |

Thermal Resistance

| Parameter | Symbol | Value | Unit |
|---|-------------------|-------|------|
| Thermal resistance, junction – case. Max | R _{thJC} | 0.62 | °C/W |
| Thermal resistance, junction – ambient. Max | R _{thJA} | 40 | |



Electrical Characteristic (at $T_j = 25^\circ\text{C}$, unless otherwise specified)

| Parameter | Symbol | Value | | | Unit | Test Condition | |
|----------------------------------|----------------------------|-------|----------------|---------|---|---|--|
| | | min. | typ. | max. | | | |
| Static Characteristic | | | | | | | |
| Drain-source breakdown voltage | BV_{DSS} | 650 | - | - | V | $\text{V}_{\text{GS}}=0\text{V}, \text{I}_d=250\mu\text{A}$ | |
| Gate threshold voltage | $\text{V}_{\text{GS(th)}}$ | 2 | - | 4 | V | $\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_d=7\text{mA}$ | |
| Zero gate voltage drain current | I_{DSS} | - | 1 10 | 100 | μA | $\text{V}_{\text{DS}}=650\text{V}, \text{V}_{\text{GS}}=0\text{V}$ $\text{T}_j=25^\circ\text{C}$ $\text{T}_j=175^\circ\text{C}$ | |
| Gate-source leakage current | I_{GSS} | - | | 250 | nA | $\text{V}_{\text{GS}}=20\text{V}, \text{V}_{\text{DS}}=0\text{V}$ | |
| Drain-source on-state resistance | $\text{R}_{\text{DS(on)}}$ | - | 45 33 50 | - 49 | m | $\text{V}_{\text{GS}}=18\text{V}, \text{I}_d=17.6\text{A},$ $\text{V}_{\text{GS}}=20\text{V}, \text{I}_d=17.6\text{A},$ $\text{T}_j=25^\circ\text{C}$ $\text{T}_j=175^\circ\text{C}$ | |
| Transconductance | g_{fs} | - | 5.6 | - | S | $\text{V}_{\text{DS}}=20\text{V}, \text{I}_d=17.6\text{A}$ | |
| Dynamic Characteristic | | | | | | | |
| Input Capacitance | C_{iss} | - | 1823 | - | pF | $\text{V}_{\text{DS}} = 650\text{V}$ $\text{V}_{\text{GS}} = 0\text{V}$ $\text{T}_J = 25^\circ\text{C}$ $\text{V}_{\text{AC}} = 25\text{mV}$ $f = 1\text{MHz}$ | |
| Output Capacitance | C_{oss} | - | 190 | - | | | |
| Reverse Transfer Capacitance | C_{rss} | - | 19 | - | | | |
| Gate Total Charge | Q_{G} | - | 96 | - | nC | $\text{V}_{\text{DS}} = 400\text{V}$ $\text{V}_{\text{GS}} = -5/20\text{V}$ $\text{I}_d = 17.6\text{A}$ | |
| Gate-Source charge | Q_{gs} | - | 25 | - | | | |
| Gate-Drain charge | Q_{gd} | - | 26 | - | | | |
| Turn-On Switching Energy | E_{ON} | - | 188 | - | μJ | $\text{V}_{\text{DD}} = 400\text{V}$ $\text{V}_{\text{GS}} = -5/+20\text{V}$ $\text{I}_d = 17.6\text{A}$ $\text{R}_G = 10$ $\text{L} = 100\mu\text{H}$ | |
| Turn-Off Switching Energy- | E_{OFF} | - | 19 | | | | |
| Turn-on delay time | $\text{t}_{\text{d(on)}}$ | - | 20 | - | | | |
| Rise time | t_r | - | 26 | - | ns | | |
| Turn-off delay time | $\text{t}_{\text{d(off)}}$ | - | 48 | - | | | |
| Fall time | t_f | - | 15 | - | | | |
| Gate resistance | R_{G} | - | 1.7 | - | $\text{V}_{\text{AC}} = 25\text{mV}, f=1\text{MHz}$ | | |



Body Diode Characteristic

| Parameter | Symbol | Value | | | Unit | Test Condition |
|------------------------------------|-----------------|-------|------|------|------|--|
| | | min. | typ. | max. | | |
| Body Diode Forward Voltage | V _{SD} | | 3.2 | | V | V _{GS} =0V, I _{SD} =8.8A, T _J =25°C |
| | | | 2.6 | | | V _{GS} =0V, I _{SD} =8.8A, T _J =175°C |
| Body Diode Reverse Recovery Time | t _{rr} | - | 40 | - | ns | V _R = 400V, I _D = 17.6A di/dt = 1000A/μS |
| Body Diode Reverse Recovery Charge | Q _{rr} | - | 156 | - | nC | |



Typical Performance Characteristics

Fig 1. Output Characteristic ($T_J = -55^\circ\text{C}$)

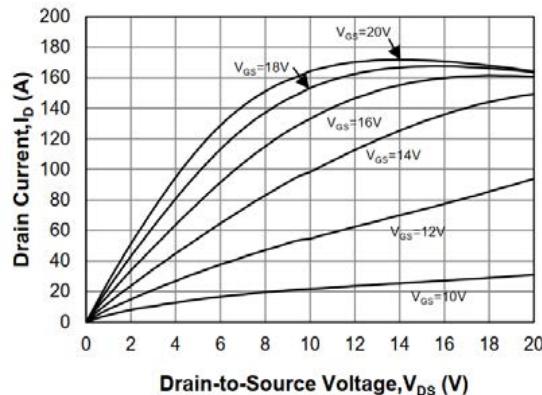


Fig 2. Output Characteristic ($T_J = 25^\circ\text{C}$)

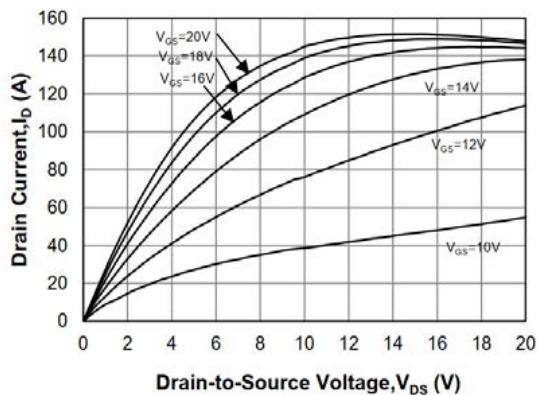


Fig 3. Output Characteristic ($T_J = 175^\circ\text{C}$)

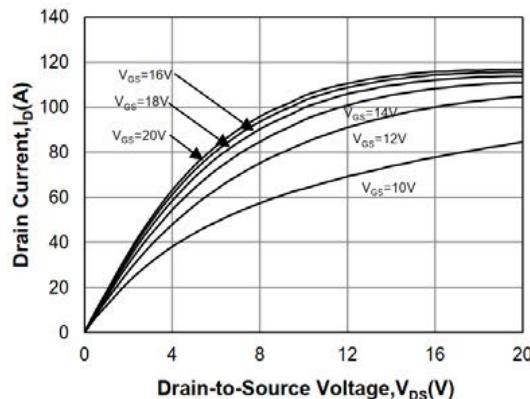


Fig 4: $R_{D(on)}$ Vs I_D Characteristic

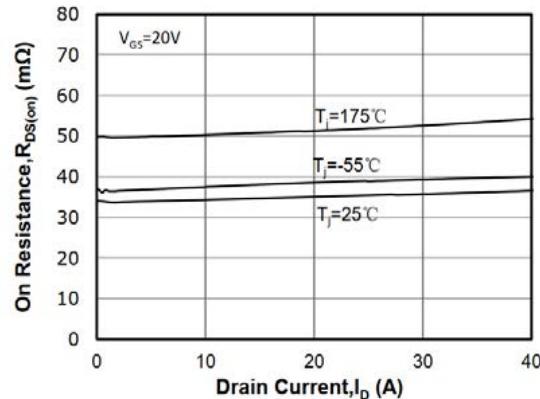


Fig 5: $R_{D(on)}$ vs. Temperature

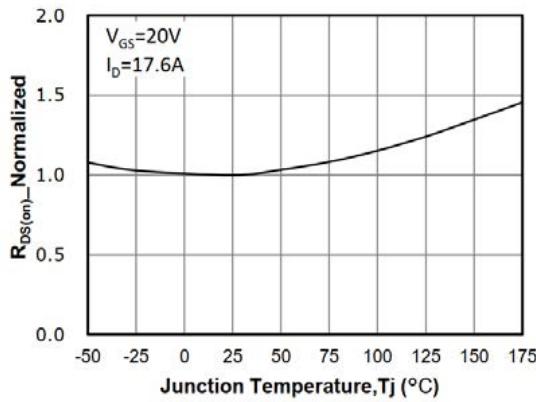


Fig 6: Transfer Characteristic

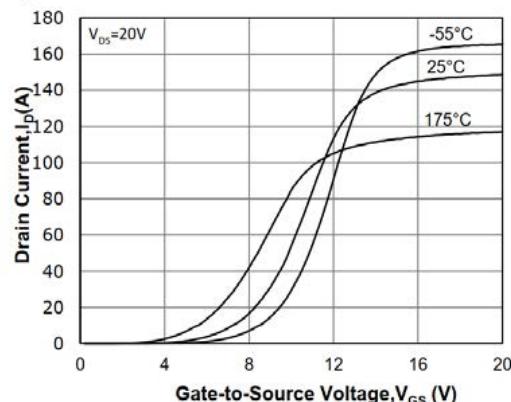




Fig 7: Body-diode Characteristic

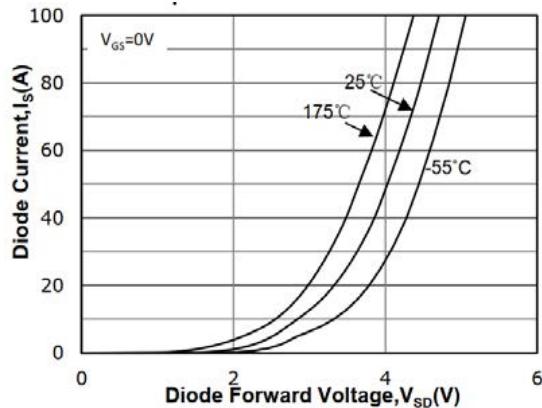


Fig 8: V_{TH} Vs T_J Temperature Characteristic

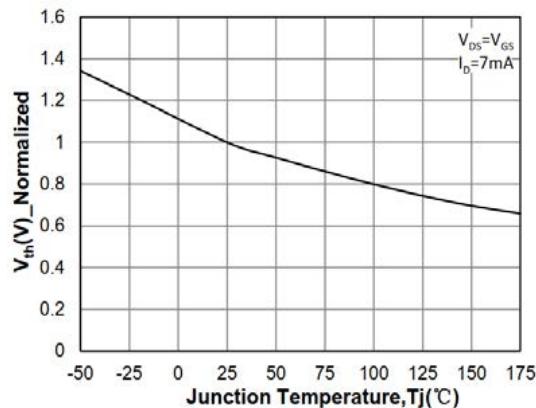


Fig 9: Gate Charge Characteristics

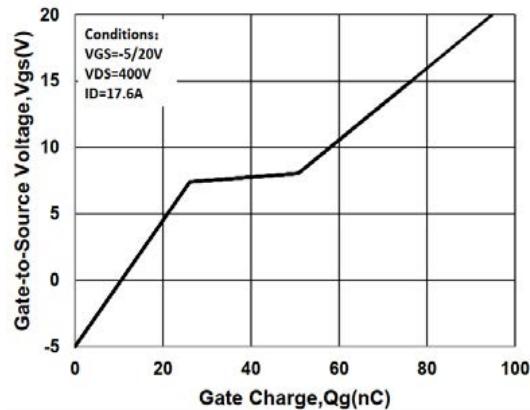


Fig 10: Continuous Drain Current vs. Case Temperature

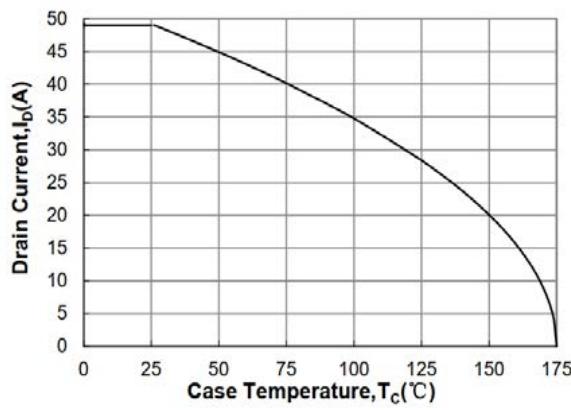


Fig 11: Safe Operating Area

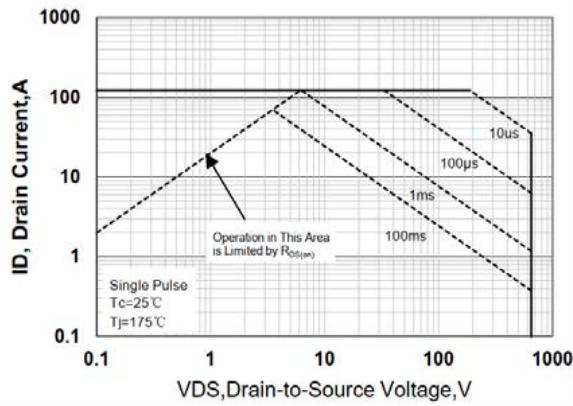


Fig 12: Capacitance Characteristics

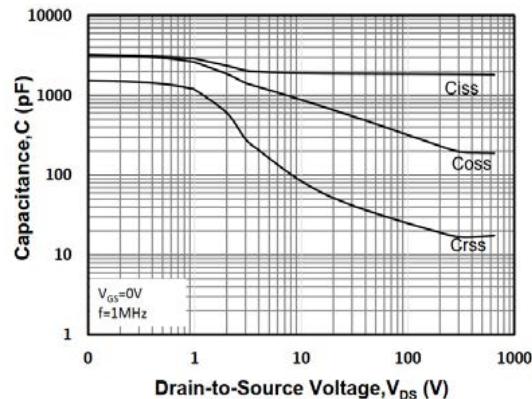
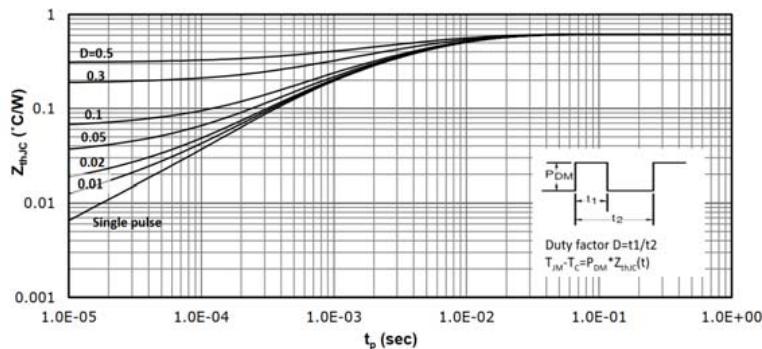




Fig 13: Transient Thermal Impedance



Test Circuit & Waveform

Figure A. Definition of switching times

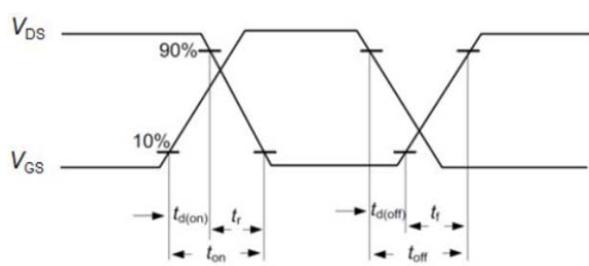


Figure B. Dynamic test circuit

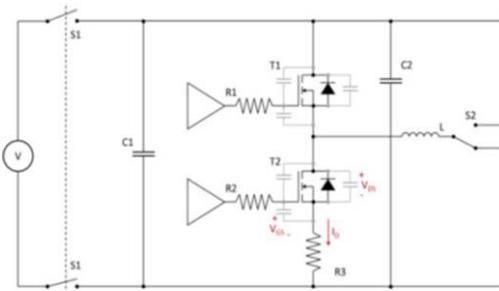
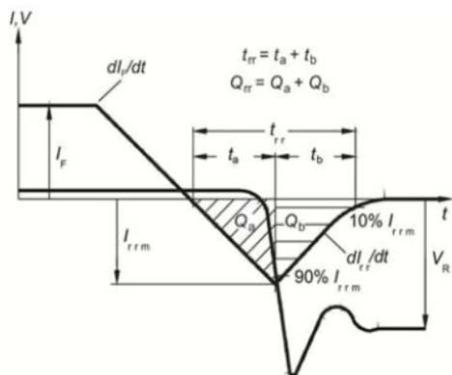


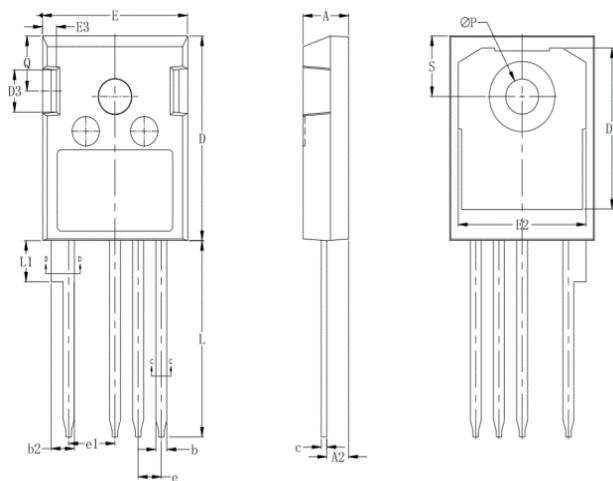
Figure C. Definition of body diodeswitching characteristics





Package Dimensions

Package TO-247-4L



| Items | Values(mm) | |
|-------|------------|------|
| | MIN | MAX |
| A | 4.8 | 5.2 |
| A2 | 2.2 | 2.6 |
| b | 1.05 | 1.4 |
| b2 | 2.4 | 2.75 |
| c | 0.5 | 0.75 |
| D | 20 | 21.5 |
| D2 | 15.5 | 17.2 |
| D3 | 4 | 5 |
| E | 15.5 | 16.1 |
| E2 | 13 | 15 |
| E3 | 1 | 2 |
| e | 2.54 BSC. | |
| e1 | 5.08 BSC. | |
| L | 19 | 21 |
| L1 | 4 | 4.45 |
| ΦP | 3.5 | 3.7 |
| Q | 5.4 | 5.9 |
| S | 5.9 | 6.4 |



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